

LPV542 双路毫微功耗 1.8V、490nA、RRIO CMOS 运算放大器

1 特性

- 宽电源电压范围: 1.6V 至 5.5V
- 低电源电流: 490nA (典型值/通道)
- 低偏移电压: 3mV (最大值/室温)
- 低 $T_c V_{os}$: 1 μ V/°C (典型值)
- 增益带宽: 8kHz (典型值)
- 轨到轨输入和输出
- 单位增益稳定
- 低输入偏置电流: 1pA (最大值/室温)
- 强化的电磁干扰 (EMI) 保护
- 温度范围: -40°C 至 125°C
- 3mm x 3mm x 0.45mm 薄型 X1SON 封装

2 应用

- 可穿戴产品
- 个人健康监视器
- 电池组
- 手机和平板电脑
- 太阳能或能量采集系统
- PIR、烟雾、燃气和火灾检测系统
- 电池供电物联网 (IoT) 设备
- 远程传感器
- 微功耗参考缓冲器

3 说明

LPV542 是一款超低功耗双路运算放大器, 带宽 8kHz, 静态电流 490nA, 是电池供电应用的理想选择, 如医疗和健身可穿戴设备、楼宇自动化和遥感节点。

每个放大器的 CMOS 输入级偏置电流仅为皮安级, 可以减少光电二极管和充电感测应用等兆欧级反馈电阻拓扑中引入的常见误差。此外, 输入共模范围扩展到电源轨, 输出摆幅扩展到电源轨的 $\pm 3mV$ 范围内, 从而保持了最宽的动态范围。同样, LPV542 设有 EMI 保护, 可降低来自手机、WiFi、无线电发射器和标签阅读器的无用射频信号对系统造成的影响。

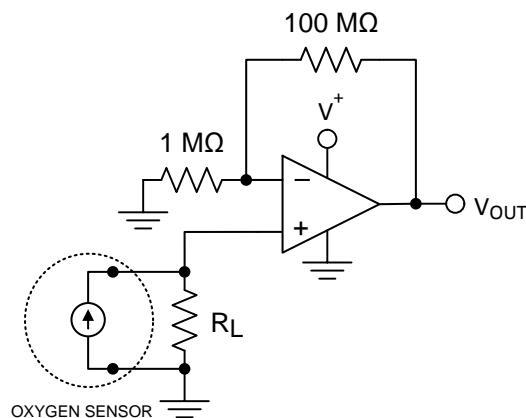
LPV542 可在 1.6V 的低电源电压下运行, 确保在电池低电量的情况下保持出色性能。该器件采用 8 焊盘 3mm x 3mm x 0.45mm 薄型无铅 X1SON 封装和标准 8 引脚 VSSOP 封装。

器件信息⁽¹⁾

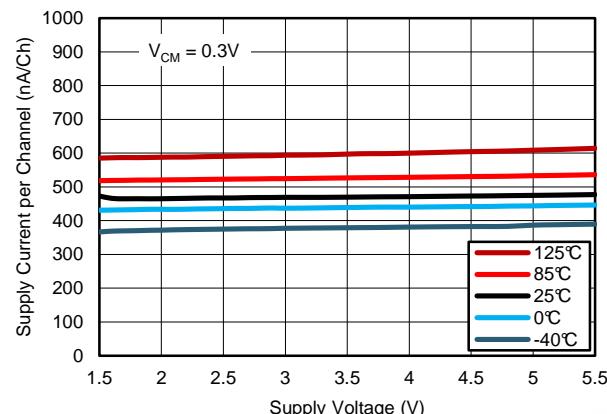
器件型号	封装	封装尺寸 (标称值)
LPV542	X1SON (8)	3.00mm x 3.00mm
	VSSOP (8)	3.00mm x 3.00mm

(1) 要了解所有可用封装, 请见数据表末尾的可订购产品附录。

毫微功耗氧气传感器放大器



电源电流与电源电压间的关系



PRODUCTION DATA information is current as of publication date. Products conform to specifications per the terms of the Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.

English Data Sheet: SNOSCX9

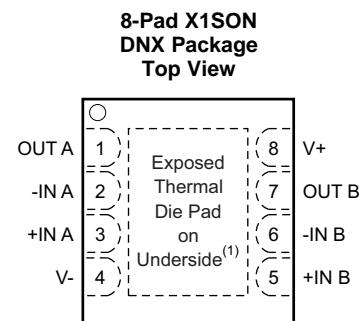
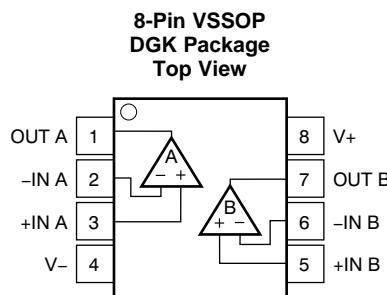
目录

1	特性	1	7.3	Feature Description.....	14
2	应用	1	7.4	Device Functional Modes.....	14
3	说明	1	8	Application and Implementation	16
4	修订历史记录	2	8.1	Application Information.....	16
5	Pin Configuration and Functions	3	8.2	Typical Application: 60 Hz Twin "T" Notch Filter.....	16
6	Specifications	4	8.3	Do's and Don'ts	17
6.1	Absolute Maximum Ratings	4	9	Power Supply Recommendations	18
6.2	ESD Ratings	4	10	Layout	18
6.3	Recommended Operating Ratings.....	4	10.1	Layout Guidelines	18
6.4	Thermal Information	4	10.2	Layout Example	18
6.5	Electrical Characteristics 1.8 V	5	11	器件和文档支持	19
6.6	Electrical Characteristics 3.3 V	6	11.1	器件支持	19
6.7	Electrical Characteristics 5 V	7	11.2	文档支持	19
6.8	Typical Characteristics	8	11.3	商标	19
7	Detailed Description	14	11.4	静电放电警告.....	19
7.1	Overview	14	11.5	术语表	19
7.2	Functional Block Diagram	14	12	机械封装和可订购信息	19

4 修订历史记录

日期	修订版本	注释
2015 年 3 月	*	最初发布。

5 Pin Configuration and Functions



(1) Connect thermal die pad to V-.

Pin Functions

PIN			I/O	DESCRIPTION
NAME	DGK	DNX		
OUT A	1	1	O	Channel A Output
-IN A	2	2	I	Channel A Inverting Input
+IN A	3	3	I	Channel A Non-Inverting Input
V-	4	4	P	Negative (lowest) power supply
+IN B	5	5	I	Channel B Non-Inverting Input
-IN B	6	6	I	Channel B Inverting Input
OUT B	7	7	O	Channel B Output
V+	8	8	P	Positive (highest) power supply
Die Pad	--	DAP	P	Die Attach Pad. Connect to V- (DNX package only)

6 Specifications

6.1 Absolute Maximum Ratings

Over operating free-air temperature range (unless otherwise noted)⁽¹⁾⁽²⁾⁽³⁾

		MIN	MAX	UNIT
Supply voltage, V ₊ to V ₋		-0.3	6	V
Signal input pins	Voltage ⁽²⁾	(V ₋) - 0.3	(V ₊) + 0.3	V
	Current ⁽²⁾	-10	10	mA
Output short current	Continuous ⁽⁴⁾			
Junction temperature		-40	150	°C
Storage temperature, T _{stg}		-65	150	°C

- (1) Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions*. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- (2) Input pins are diode-clamped to the power-supply rails. Input signals that can swing more than 0.3 V beyond the supply rails should be current-limited to 10 mA or less.
- (3) If Military/Aerospace specified devices are required, please contact the Texas Instruments Sales Office/Distributors for availability and specifications.
- (4) Short-circuit to V₋.

6.2 ESD Ratings

		VALUE	UNIT
V _(ESD)	Human body model (HBM), per ANSI/ESDA/JEDEC JS-001, all pins ⁽¹⁾	±2000	V
	Charged device model (CDM), per JEDEC specification JESD22-C101, all pins ⁽²⁾	±250	

(1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

(2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

6.3 Recommended Operating Ratings

	MIN	NOM	MAX	UNIT
Supply Voltage (V ₊ – V ₋)	1.6		5.5	V
Specified Temperature	-40		125	°C

6.4 Thermal Information

THERMAL METRIC ⁽¹⁾		DGK (VSSOP) 8 PINS	DNX (X1SON) 8 PINS	UNIT
R _{θJA}	Junction-to-ambient thermal resistance		46.3	°C/W
R _{θJC(top)}	Junction-to-case (top) thermal resistance		33.3	
R _{θJB}	Junction-to-board thermal resistance		21	
Ψ _{JT}	Junction-to-top characterization parameter		0.2	
Ψ _{JB}	Junction-to-board characterization parameter		21.2	
R _{θJC(bot)}	Junction-to-case (bottom) thermal resistance		7	

- (1) For more information about traditional and new thermal metrics, see the IC Package Thermal Metrics application report, [SPRA953](#).

6.5 Electrical Characteristics 1.8 V

$T_A = 25^\circ\text{C}$, $V^+ = 1.8\text{V}$, $V^- = 0\text{V}$, $V_{CM} = V_O = V^+/2$, and $R_L > 1\text{M}\Omega$, unless otherwise noted.

PARAMETER	TEST CONDITIONS	MIN	TYP ⁽¹⁾	MAX	UNIT
OFFSET VOLTAGE					
Input offset voltage (V_{OS})	$V_{CM} = 0.3\text{ V}$		± 1	± 2	mV
	$V_{CM} = 1.5\text{ V}$		± 1	± 3	
Over temperature	$V_{CM} = 0.3\text{ V}$ and 1.5 V			± 4	
Drift (dV_{OS}/dT)			1		$\mu\text{V}/^\circ\text{C}$
Power-Supply Rejection Ratio (PSRR)	$V_S = 1.6\text{ V}$ to 5.5 V , $V_{CM} = 0.3\text{ V}$	83	109		dB
INPUT VOLTAGE RANGE					
Common-mode voltage range (V_{CM})	CMRR $\geq 60\text{ dB}$	0	1.8		V
Common-Mode Rejection Ratio (CMRR)	$0\text{ V} < V_{CM} < 1.8\text{ V}$	63	92		dB
	$0\text{ V} < V_{CM} < 0.7\text{ V}$	87	92		
	$1.3\text{ V} < V_{CM} < 1.8\text{ V}$	63	98		
INPUT BIAS CURRENT					
Input bias current (I_B)	$T_A = 25^\circ\text{C}$		± 0.1	± 1	pA
	$T_A = -40^\circ\text{C}$ to 125°C			± 100	
Input offset current (I_{OS})			± 0.1	± 1	
INPUT IMPEDANCE					
Differential		$10^{13} \parallel 2.5$			$\Omega \parallel \text{pF}$
Common mode		$10^{13} \parallel 2.5$			
NOISE					
Input voltage noise density, $f = 1\text{ kHz}$ (e_n)		250			$\text{nV}/\sqrt{\text{Hz}}$
Current noise density, $f = 1\text{ kHz}$ (i_n)		80			$\text{fA}/\sqrt{\text{Hz}}$
OPEN-LOOP GAIN					
Open-loop voltage gain (A_{OL})	$R_L = 100\text{ k}\Omega$ to $V^+/2$, $0.5\text{ V} < V_O < 1.3\text{ V}$	91	101		dB
OUTPUT					
Voltage output swing from positive rail	$R_L = 100\text{ k}\Omega$ to $V^+/2$	3	20		mV
Voltage output swing from negative rail	$R_L = 100\text{ k}\Omega$ to $V^-/2$	2	20		
Output current sourcing	Sourcing, V_O to V^- , $V_{IN}(\text{diff}) = 100\text{ mV}$	1	3		mA
Output current sinking	Sinking, V_O to V^+ , $V_{IN}(\text{diff}) = -100\text{ mV}$	1	5		
FREQUENCY RESPONSE					
Gain-bandwidth product (GBWP)	$C_L = 20\text{ pF}$	7			kHz
Slew rate (SR)	$G = +1$, Rising edge, $1V_{p-p}$, $C_L = 20\text{ pF}$	3.4			V/ms
	$G = +1$, Falling edge, $1V_{p-p}$, $C_L = 20\text{ pF}$	3.7			
POWER SUPPLY					
Specified voltage range (V_S)		1.6	5.5		V
Quiescent current per channel (I_Q)	$V_{CM} = 0.3\text{ V}$, $I_O = 0$	490	800		nA
Over temperature				1100	
Quiescent current per channel (I_Q)	$V_{CM} = 1.5\text{ V}$, $I_O = 0$	680	1100		
Over temperature				1500	

(1) Refer to [Typical Characteristics](#).

6.6 Electrical Characteristics 3.3 V

$T_A = 25^\circ\text{C}$, $V^+ = 3.3\text{V}$, $V^- = 0\text{V}$, $V_{\text{CM}} = V_O = V^+/2$, and $R_L > 1\text{ M}\Omega$, unless otherwise noted.

PARAMETER	TEST CONDITIONS	MIN	TYP ⁽¹⁾	MAX	UNIT
OFFSET VOLTAGE					
Input offset voltage (V_{OS})	$V_{\text{CM}} = 0.3$		± 1	± 2	mV
	$V_{\text{CM}} = 3\text{ V}$		± 1	± 3	
Over temperature	$V_{\text{CM}} = 0.3\text{ V}$ and 3 V			± 4	
Drift (dV_{OS}/dT)			1		$\mu\text{V}/^\circ\text{C}$
Power-Supply Rejection Ratio (PSRR)	$V_S = 1.6\text{ V}$ to 5.5 V , $V_{\text{CM}} = 0.3\text{ V}$	83	109		dB
INPUT VOLTAGE RANGE					
Common-mode voltage range (V_{CM})	$\text{CMRR} \geq 60\text{ dB}$	0	3.3		V
Common-Mode Rejection Ratio (CMRR)	$0\text{ V} < V_{\text{CM}} < 3.3\text{ V}$	64	98		dB
	$0\text{ V} < V_{\text{CM}} < 2.2\text{ V}$	88	98		
	$2.7\text{ V} < V_{\text{CM}} < 3.3\text{ V}$	64	105		
INPUT BIAS CURRENT					
Input bias current (I_B)	$T_A = 25^\circ\text{C}$		± 0.1	± 1	pA
	$T_A = -40^\circ\text{C}$ to 125°C			± 100	
Input offset current (I_{OS})			± 0.1	± 1	
INPUT IMPEDANCE					
Differential		$10^{13} \parallel 2.5$			$\Omega \parallel \text{pF}$
Common mode		$10^{13} \parallel 2.5$			
NOISE					
Input voltage noise density, $f = 1\text{ kHz}$ (e_n)		250			$\text{nV}/\sqrt{\text{Hz}}$
Current noise density, $f = 1\text{ kHz}$ (i_n)		60			$\text{fA}/\sqrt{\text{Hz}}$
OPEN-LOOP GAIN					
Open-loop voltage gain (A_{OL})	$R_L = 100\text{ k}\Omega$ to $V^+/2$, $0.5\text{ V} < V_O < 2.8\text{ V}$	91	101		dB
OUTPUT					
Voltage output swing from positive Rail	$R_L = 100\text{ k}\Omega$ to $V^+/2$	3	20		mV
Voltage output swing from negative Rail	$R_L = 100\text{ k}\Omega$ to $V^+/2$	2	20		
Output current sourcing	Sourcing, V_O to V^- , $V_{\text{IN}}(\text{diff}) = 100\text{ mV}$	5	14		mA
Output current sinking	Sinking, V_O to V^+ , $V_{\text{IN}}(\text{diff}) = -100\text{ mV}$	5	19		
FREQUENCY RESPONSE					
Gain-bandwidth product (GBWP)	$C_L = 20\text{ pF}$	8			kHz
Slew rate (SR)	$G = +1$, Rising edge, $1V_{\text{p-p}}$, $C_L = 20\text{ pF}$	3.6			V/ms
	$G = +1$, Falling edge, $1V_{\text{p-p}}$, $C_L = 20\text{ pF}$	3.7			
POWER SUPPLY					
Specified voltage range (V_S)		1.6	5.5		V
Quiescent current per channel (I_Q)	$V_{\text{CM}} = 0.3\text{ V}$, $I_O = 0$	480	800		nA
Over temperature			1200		
Quiescent current per channel (I_Q)	$V_{\text{CM}} = 3\text{ V}$, $I_O = 0$	650	1100		
Over temperature			1500		

(1) Refer to [Typical Characteristics](#).

6.7 Electrical Characteristics 5 V

$T_A = 25^\circ\text{C}$, $V^+ = 5\text{ V}$, $V^- = 0\text{ V}$, $V_{\text{CM}} = V_O = V^+/2$, and $R_L > 1\text{ M}\Omega$, unless otherwise noted.

PARAMETER	TEST CONDITIONS	MIN	TYP ⁽¹⁾	MAX	UNIT
OFFSET VOLTAGE					
Input offset voltage (V_{OS})	$V_{\text{CM}} = 0.3\text{ V}$		± 1	± 2	mV
	$V_{\text{CM}} = 4.7\text{ V}$		± 1	± 3	
Over temperature	$V_{\text{CM}} = 0.3\text{ V}$ and 4.7 V			± 4	
Drift (dV_{OS}/dT)			1		$\mu\text{V}/^\circ\text{C}$
Power-Supply Rejection Ratio (PSRR)	$V_S = 1.6\text{ V}$ to 5.5 V , $V_{\text{CM}} = 0.3\text{ V}$	83	109		dB
INPUT VOLTAGE RANGE					
Common-Mode voltage range (V_{CM})	$\text{CMRR} \geq 60\text{ dB}$	0	5		V
Common-Mode Rejection Ratio (CMRR)	$0\text{ V} < V_{\text{CM}} < 5\text{ V}$	73	101		dB
	$0\text{ V} < V_{\text{CM}} < 3.9\text{ V}$	88	101		
	$4.4\text{ V} < V_{\text{CM}} < 5\text{ V}$	73	109		
INPUT BIAS CURRENT					
Input bias current (I_B)	$T_A = 25^\circ\text{C}$		± 0.1	± 1	pA
	$T_A = -40^\circ\text{C}$ to 125°C			± 100	
Input offset current (I_{OS})			± 0.1	± 1	
INPUT IMPEDANCE					
Differential		$10^{13} \parallel 2.5$			$\Omega \parallel \text{pF}$
Common mode		$10^{13} \parallel 2.5$			
NOISE					
Input voltage noise density, $f = 1\text{ kHz}$ (e_n)		250			$\text{nV}/\sqrt{\text{Hz}}$
Current noise density, $f = 1\text{ kHz}$ (i_n)		65			$\text{fA}/\sqrt{\text{Hz}}$
OPEN-LOOP GAIN					
Open-loop voltage gain (A_{OL})	$R_L = 100\text{ k}\Omega$ to $V^+/2$, $0.5\text{ V} < V_O < 4.5\text{ V}$	91	101		dB
OUTPUT					
Voltage output swing from positive rail	$R_L = 100\text{ k}\Omega$ to $V^+/2$	3	20		mV
Voltage output swing from negative rail	$R_L = 100\text{ k}\Omega$ to $V^-/2$	2	20		
Output current sourcing	Sourcing, V_O to V^- , $V_{\text{IN}}(\text{diff}) = 100\text{ mV}$	10	30		mA
Output current sinking	Sinking, V_O to V^+ , $V_{\text{IN}}(\text{diff}) = -100\text{ mV}$	10	36		
FREQUENCY RESPONSE					
Gain-bandwidth product (GBWP)	$C_L = 20\text{ pF}$	8			kHz
Slew rate (SR)	$G = +1$, Rising edge, $1V_{\text{p-p}}$, $C_L = 20\text{ pF}$	3.6			V/ms
	$G = +1$, Falling edge, $1V_{\text{p-p}}$, $C_L = 20\text{ pF}$	3.7			
POWER SUPPLY					
Specified voltage range (V_S)		1.6	5.5		V
Quiescent current per channel (I_Q)	$V_{\text{CM}} = 0.3\text{ V}$, $I_O = 0$	480	850		nA
Over temperature			1300		
Quiescent current per channel (I_Q)	$V_{\text{CM}} = 4.7\text{ V}$, $I_O = 0$	680	1100		
Over temperature			1600		

(1) Refer to [Typical Characteristics](#).

6.8 Typical Characteristics

$T_A = 25^\circ\text{C}$, $V_S = 5\text{ V}$, $V_{\text{OUT}} = V_{\text{CM}} = V_S/2$, $R_{\text{LOAD}} = 1\text{ M}\Omega$ connected to $V_S/2$, and $C_L = 20\text{ pF}$, unless otherwise noted.

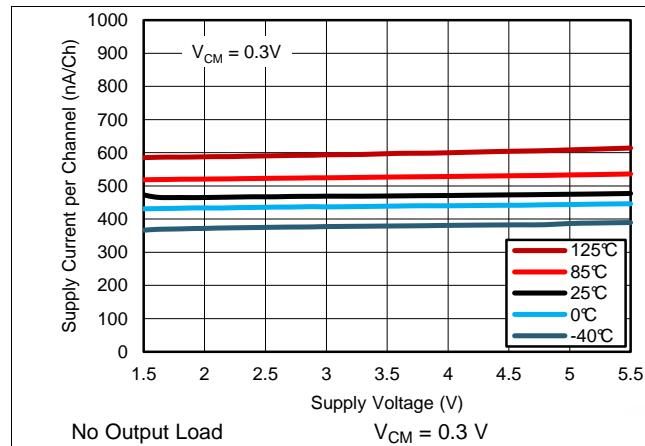


Figure 1. Supply Voltage vs Supply Current per Channel, Low V_{cm}

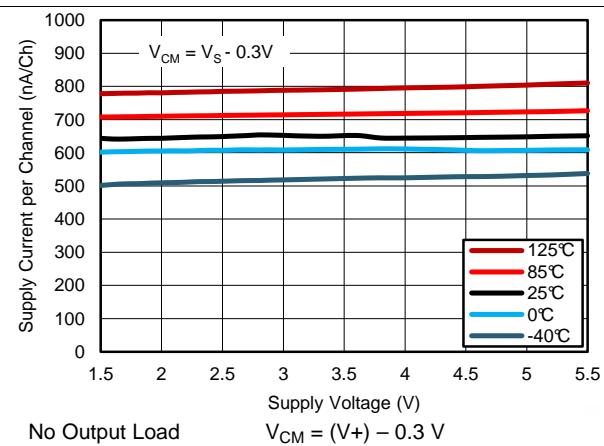


Figure 2. Supply Voltage vs Supply Current per Channel, High V_{cm}

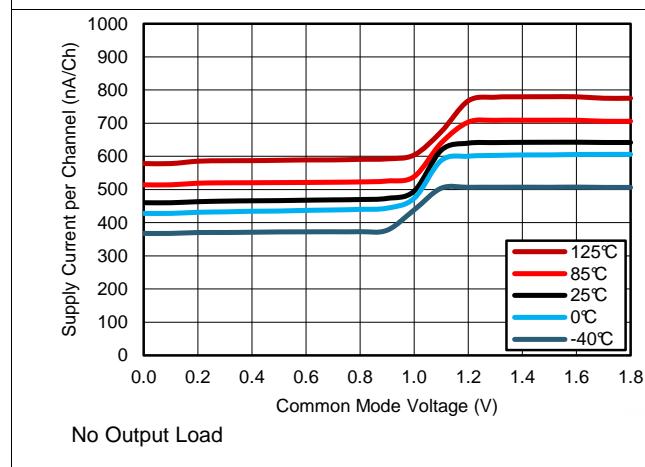


Figure 3. Supply Current vs Common Mode at 1.8 V

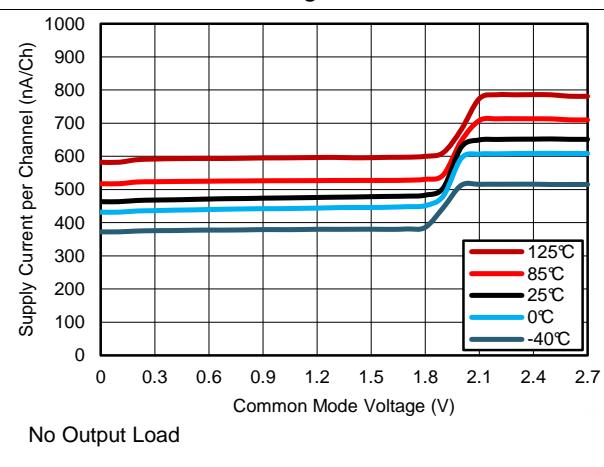


Figure 4. Supply Current vs Common Mode at 2.7 V

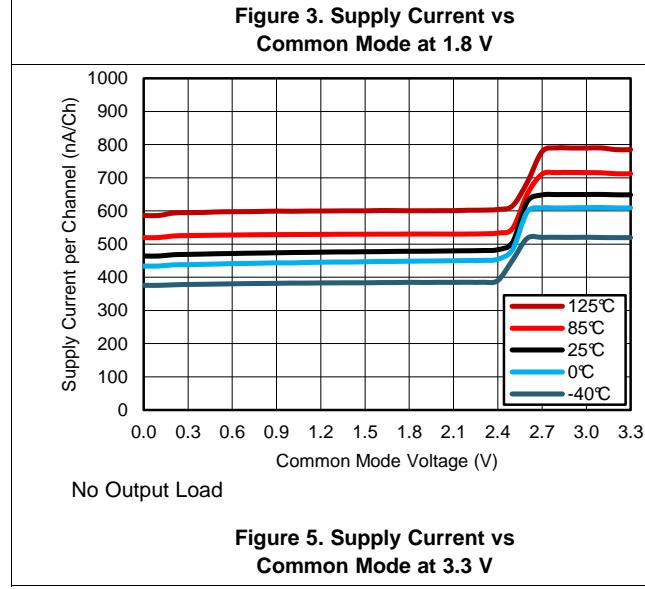


Figure 5. Supply Current vs Common Mode at 3.3 V

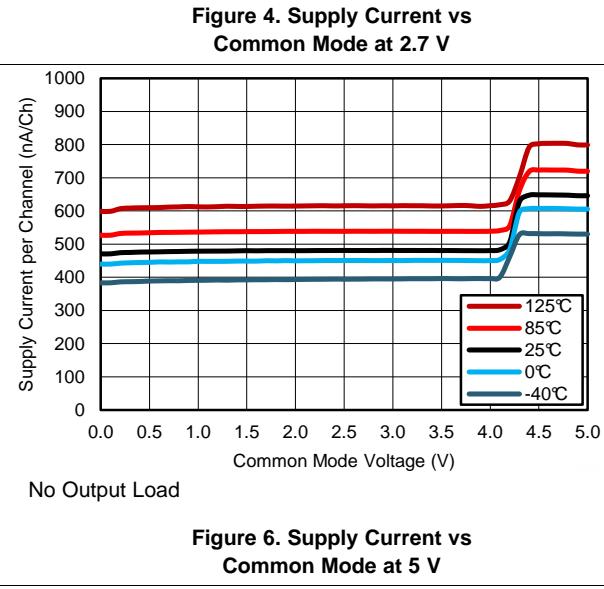


Figure 6. Supply Current vs Common Mode at 5 V

Typical Characteristics (continued)

$T_A = 25^\circ\text{C}$, $V_S = 5\text{ V}$, $V_{\text{OUT}} = V_{\text{CM}} = V_S/2$, $R_{\text{LOAD}} = 1\text{ M}\Omega$ connected to $V_S/2$, and $C_L = 20\text{ pF}$, unless otherwise noted.

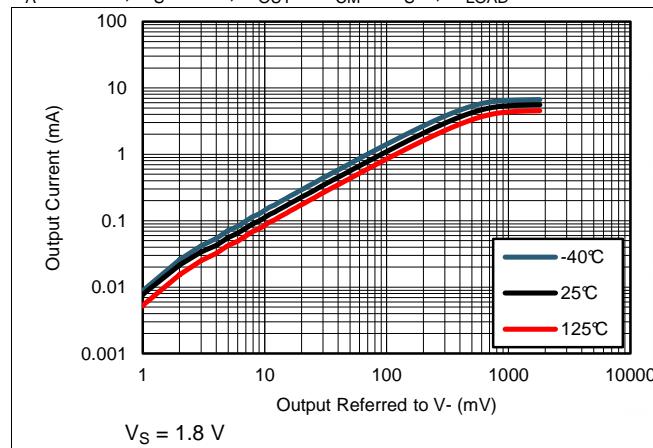


Figure 7. Output Sinking Current vs Output Swing at 1.8 V

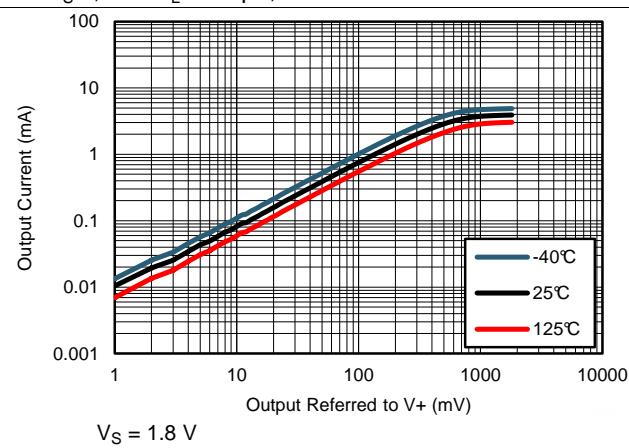


Figure 8. Output Sourcing Current vs Output Swing at 1.8 V

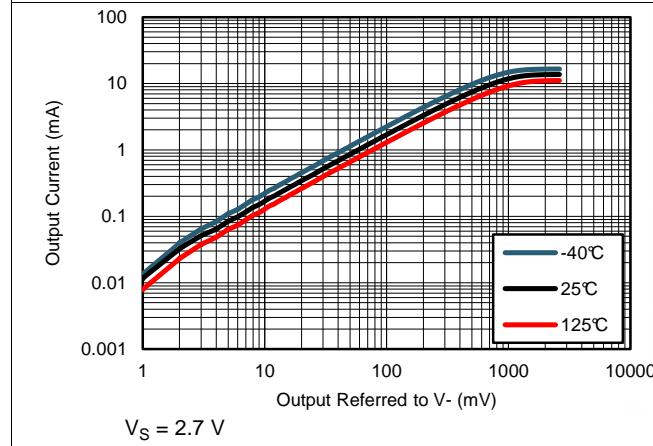


Figure 9. Output Sinking Current vs Output Swing at 2.7 V

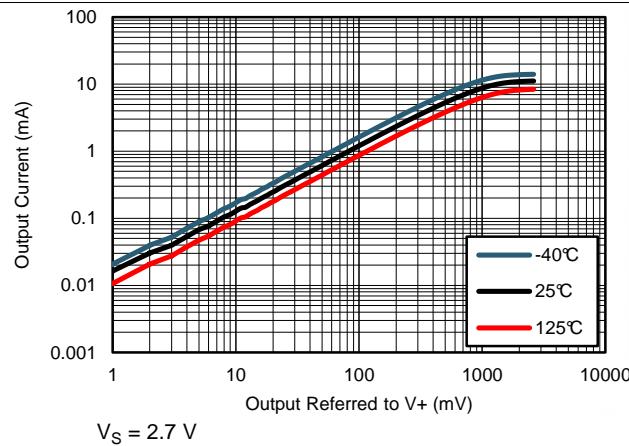


Figure 10. Output Sourcing Current vs Output Swing at 2.7 V

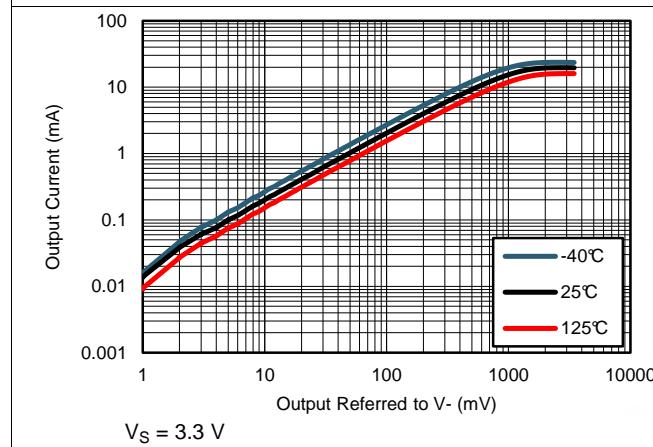


Figure 11. Output Sinking Current vs Output Swing at 3.3 V

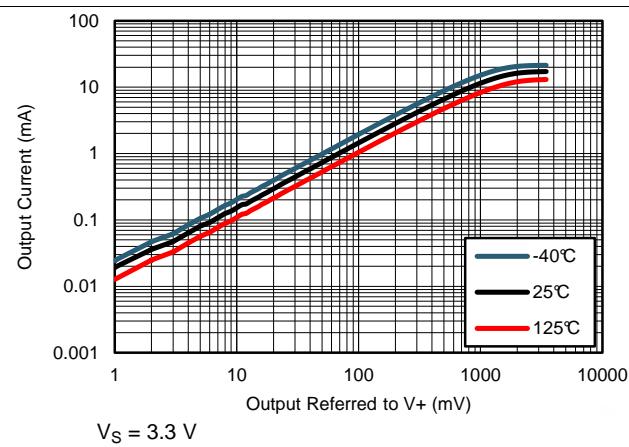


Figure 12. Output Sourcing Current vs Output Swing at 3.3 V

Typical Characteristics (continued)

$T_A = 25^\circ\text{C}$, $V_S = 5\text{ V}$, $V_{\text{OUT}} = V_{\text{CM}} = V_S/2$, $R_{\text{LOAD}} = 1\text{ M}\Omega$ connected to $V_S/2$, and $C_L = 20\text{ pF}$, unless otherwise noted.

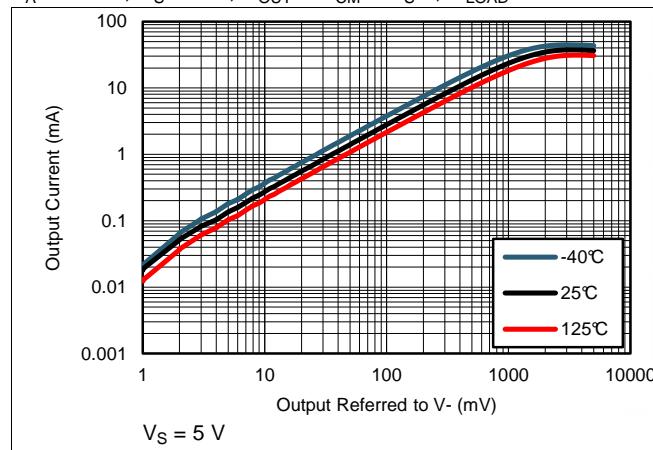


Figure 13. Output Sinking Current vs Output Swing at 5 V

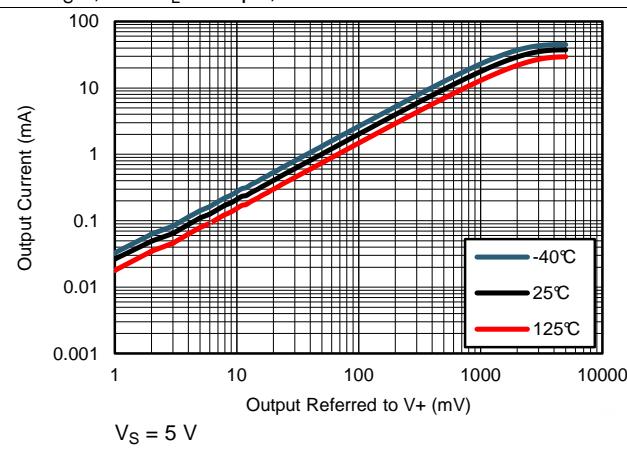


Figure 14. Output Sourcing Current vs Output Swing at 5 V

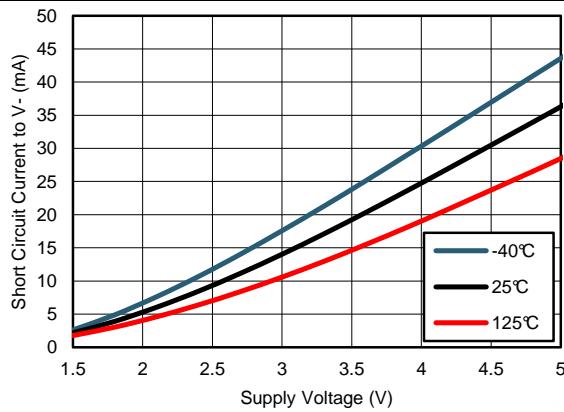


Figure 15. Output Short Circuit Current to V_- vs Supply Voltage

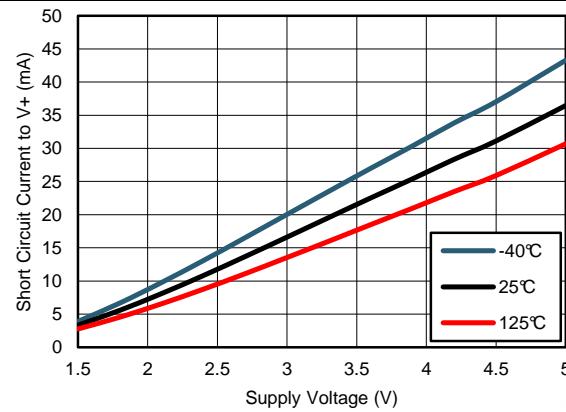


Figure 16. Output Short Circuit Current to V_+ vs Supply Voltage

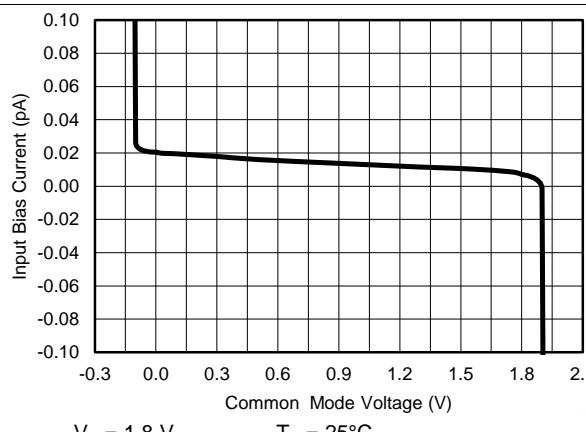


Figure 17. Input Bias Current vs Common Mode Voltage at 1.8 V

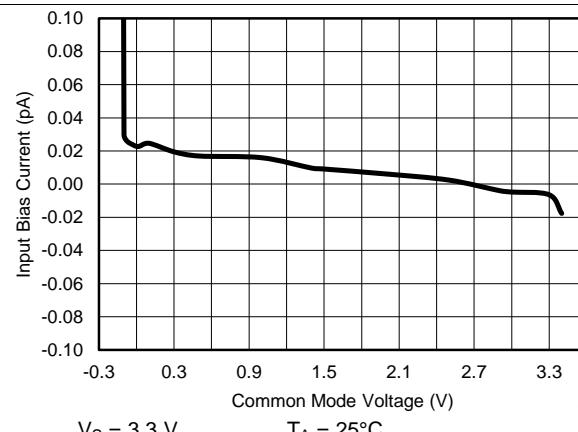


Figure 18. Input Bias Current vs Common Mode Voltage at 3.3V

Typical Characteristics (continued)

$T_A = 25^\circ\text{C}$, $V_S = 5\text{ V}$, $V_{\text{OUT}} = V_{\text{CM}} = V_S/2$, $R_{\text{LOAD}} = 1\text{ M}\Omega$ connected to $V_S/2$, and $C_L = 20\text{ pF}$, unless otherwise noted.

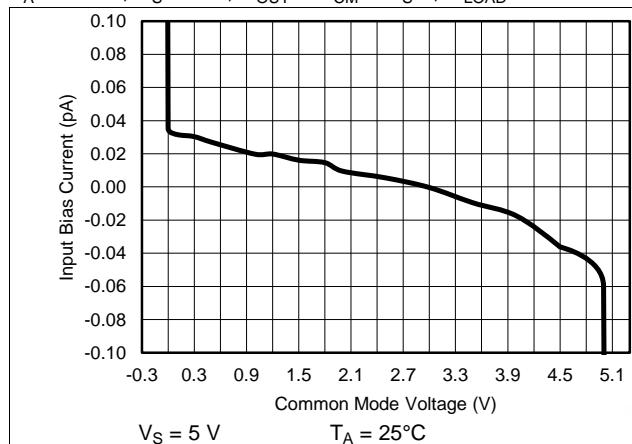


Figure 19. Input Bias Current vs Common Mode Voltage at 5V

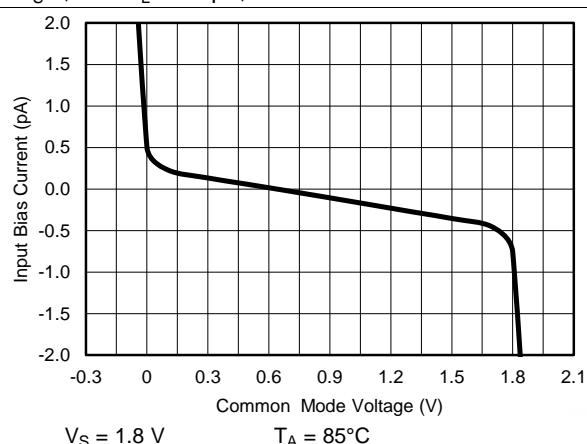


Figure 20. Input Bias Current vs Common Mode Voltage at 1.8V

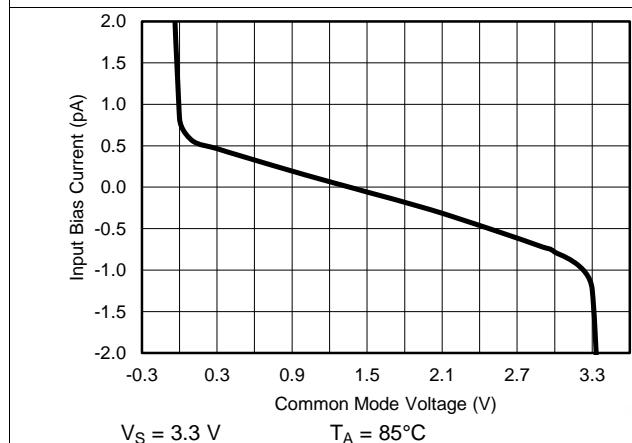


Figure 21. Input Bias Current vs Common Mode Voltage at 3.3V

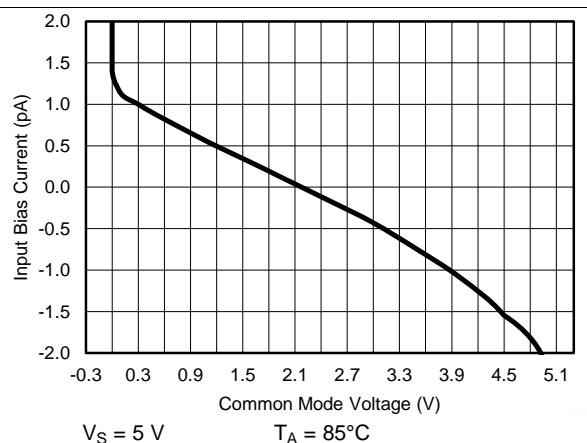


Figure 22. Input Bias Current vs Common Mode Voltage at 5V

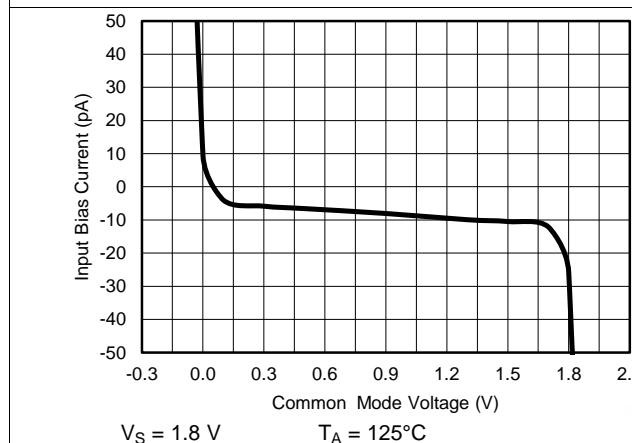


Figure 23. Input Bias Current vs Common Mode Voltage at 1.8V

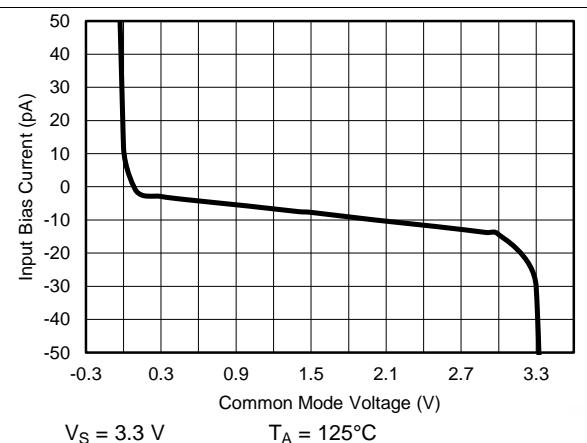


Figure 24. Input Bias Current vs Common Mode Voltage at 3.3V

Typical Characteristics (continued)

$T_A = 25^\circ\text{C}$, $V_S = 5\text{ V}$, $V_{\text{OUT}} = V_{\text{CM}} = V_S/2$, $R_{\text{LOAD}} = 1\text{ M}\Omega$ connected to $V_S/2$, and $C_L = 20\text{ pF}$, unless otherwise noted.

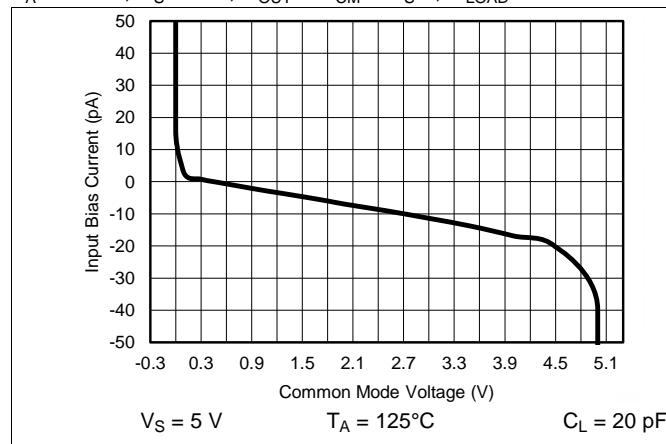


Figure 25. Input Bias Current vs Common Mode Voltage at 5 V

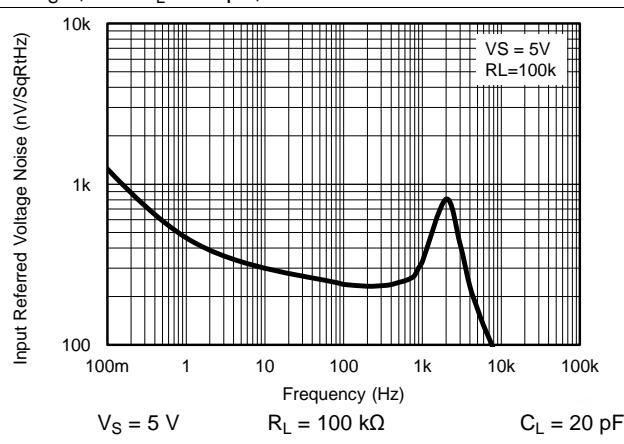


Figure 26. Input Referred Voltage Noise

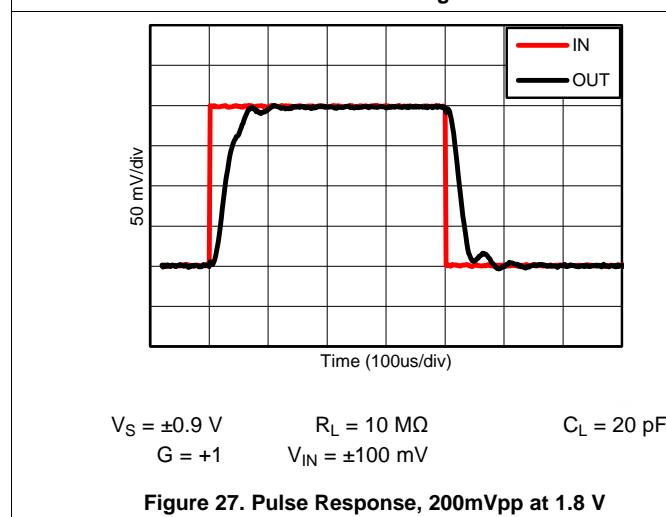


Figure 27. Pulse Response, 200mVpp at 1.8 V

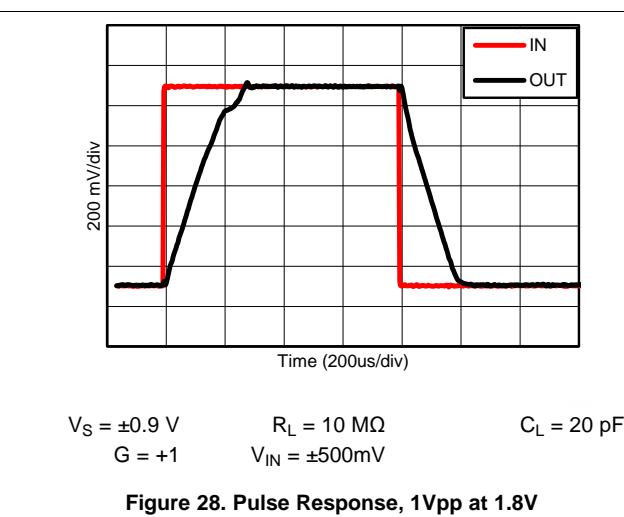


Figure 28. Pulse Response, 1Vpp at 1.8 V

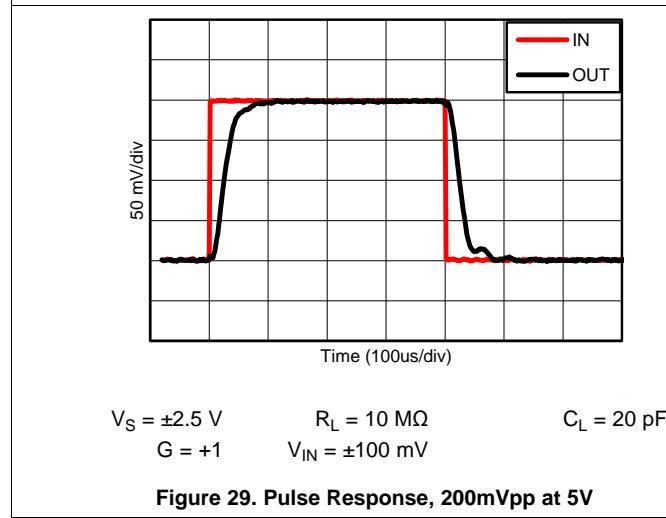


Figure 29. Pulse Response, 200mVpp at 5V

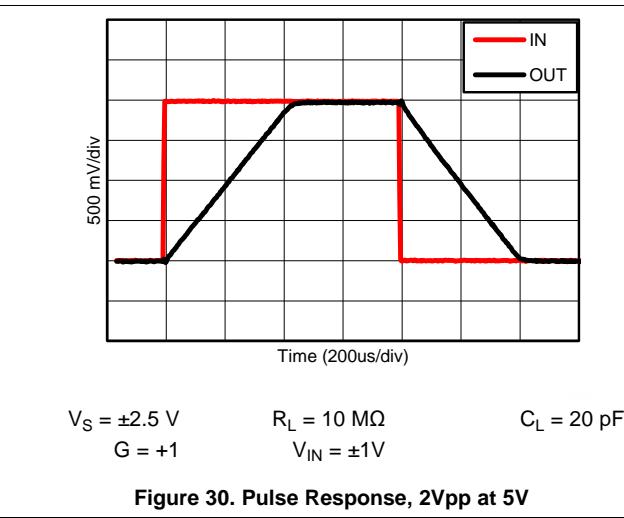


Figure 30. Pulse Response, 2Vpp at 5V

Typical Characteristics (continued)

$T_A = 25^\circ\text{C}$, $V_S = 5\text{ V}$, $V_{\text{OUT}} = V_{\text{CM}} = V_S/2$, $R_{\text{LOAD}} = 1\text{ M}\Omega$ connected to $V_S/2$, and $C_L = 20\text{ pF}$, unless otherwise noted.

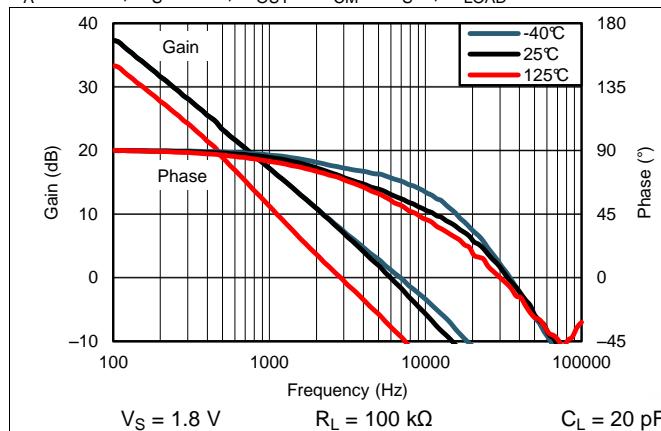


Figure 31. Gain and Phase vs Temperature at 1.8 V

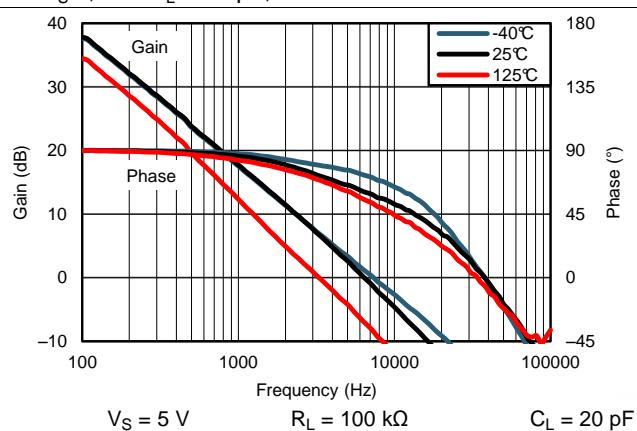


Figure 32. Gain and Phase vs Temperature at 5 V

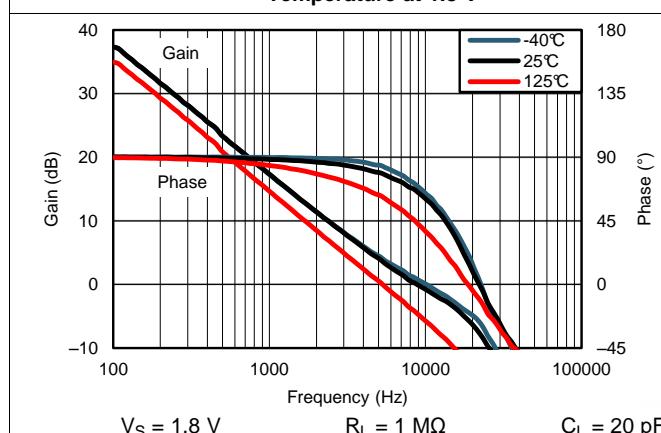


Figure 33. Gain and Phase vs Temperature at 1.8 V

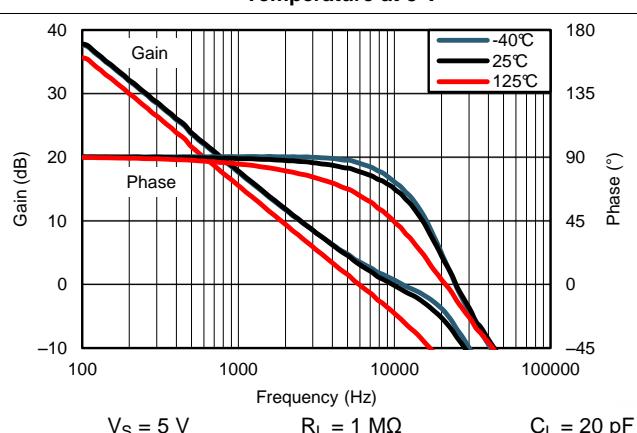


Figure 34. Gain and Phase vs Temperature at 5 V

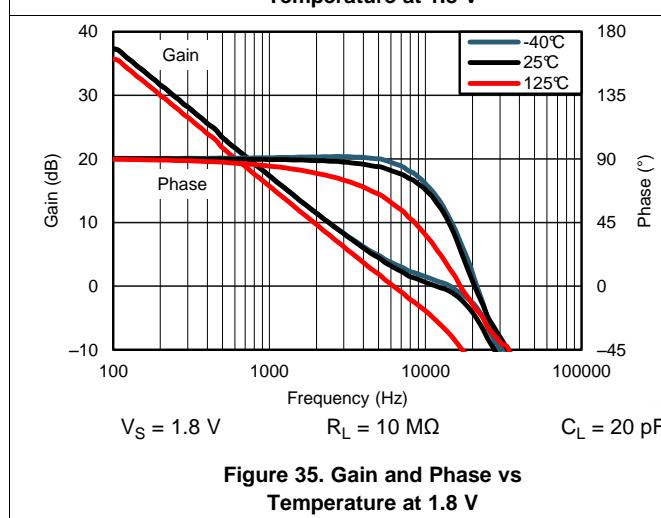


Figure 35. Gain and Phase vs Temperature at 1.8 V

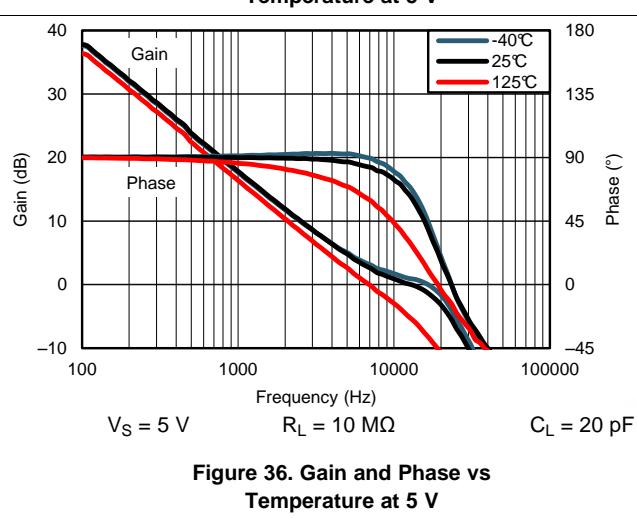


Figure 36. Gain and Phase vs Temperature at 5 V

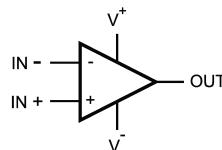
7 Detailed Description

7.1 Overview

The LPV542 dual op amplifier is unity-gain stable and can operate on a single supply, making it highly versatile and easy to use.

The LPV542 is fully specified and tested from 1.6 V to 5.5 V. Parameters that vary significantly with operating voltages or temperature are shown in the *Typical Characteristics* curves.

7.2 Functional Block Diagram



7.3 Feature Description

The amplifier's differential inputs consist of a non-inverting input (+IN) and an inverting input (-IN). The amplifier amplifies only the difference in voltage between the two inputs, which is called the differential input voltage. The output voltage of the op-amp V_{OUT} is given by [Equation 1](#):

$$V_{OUT} = A_{OL} (IN^+ - IN^-)$$

where

- A_{OL} is the open-loop gain of the amplifier, typically around 100 dB (100,000x, or 100,000 Volts per microvolt). (1)

7.4 Device Functional Modes

7.4.1 Rail-To-Rail Input

The input common-mode voltage range of the LPV542 extends to the supply rails. This is achieved with a complementary input stage — an N-channel input differential pair in parallel with a P-channel differential pair. The N-channel pair is active for input voltages close to the positive rail, typically $(V_+) - 800$ mV to 200 mV above the positive supply, while the P-channel pair is on for inputs from 300 mV below the negative supply to approximately $(V_+) - 800$ mV. There is a small transition region, typically $(V_+) - 1.2$ V to $(V_+) - 0.8$ V, in which both pairs are on. This 400 mV transition region can vary 200 mV with process variation. Within the 400 mV transition region PSRR, CMRR, offset voltage, offset drift, and THD may be degraded compared to operation outside this region.

7.4.2 Supply Current Changes over Common Mode

Because of the ultra-low supply current, changes in common mode voltages will cause a noticeable change in the supply current as the input stages transition through the transition region, as shown in [Figure 37](#) below.

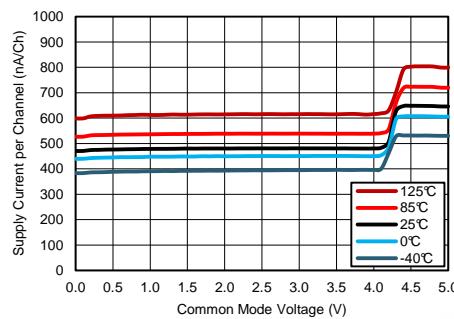


Figure 37. Supply Current Change over Common Mode at 5 V

Device Functional Modes (continued)

For the lowest supply current operation, keep the input common mode range between V_- and 1 V below V_+ .

7.4.3 Design Optimization With Rail-To-Rail Input

In most applications, operation is within the range of only one differential pair. However, some applications can subject the amplifier to a common-mode signal in the transition region. Under this condition, the inherent mismatch between the two differential pairs may lead to degradation of the CMRR and THD. The unity-gain buffer configuration is the most problematic as it will traverse through the transition region if a sufficiently wide input swing is required.

7.4.4 Design Optimization for Nanopower Operation

When designing for ultralow power, choose system components carefully. To minimize current consumption, select large-value resistors. Any resistors will react with stray capacitance in the circuit and the input capacitance of the operational amplifier. These parasitic RC combinations can affect the stability of the overall system. A feedback capacitor may be required to assure stability and limit overshoot or gain peaking.

When possible, use AC coupling and AC feedback to reduce static current draw through the feedback elements. Use film or ceramic capacitors since large electrolytics may have static leakage currents in the tens to hundreds of nanoamps.

7.4.5 Common-Mode Rejection

The CMRR for the LPV542 is specified in two ways so the best match for a given application may be used. First, the CMRR of the device in the common-mode range below the transition region ($V_{CM} < (V_+) - 0.9$ V) is given. This specification is the best indicator of the capability of the device when the application requires use of one of the differential input pairs. Second, the CMRR at $V_S = 5$ V over the entire common-mode range is specified.

7.4.6 Output Stage

The LPV542 output voltage swings 3 mV from rails at 3.3 V supply, which provides the maximum possible dynamic range at the output. This is particularly important when operating on low supply voltages.

The LPV542 Maximum Output Voltage Swing defines the maximum swing possible under a particular output load.

7.4.7 Driving Capacitive Load

The LPV542 is internally compensated for stable unity gain operation, with a 8 kHz typical gain bandwidth. However, the unity gain follower is the most sensitive configuration to capacitive load. The combination of a capacitive load placed directly on the output of an amplifier along with the amplifier's output impedance creates a phase lag, which reduces the phase margin of the amplifier. If the phase margin is significantly reduced, the response will be under damped which causes peaking in the transfer and, when there is too much peaking, the op amp might start oscillating.

In order to drive heavy (>50 pF) capacitive loads, an isolation resistor, R_{ISO} , should be used, as shown in [Figure 38](#). By using this isolation resistor, the capacitive load is isolated from the amplifier's output. The larger the value of R_{ISO} , the more stable the amplifier will be. If the value of R_{ISO} is sufficiently large, the feedback loop will be stable, independent of the value of C_L . However, larger values of R_{ISO} result in reduced output swing and reduced output current drive.

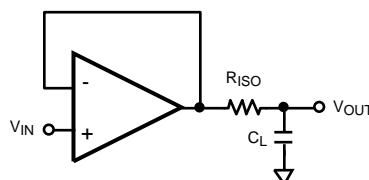


Figure 38. Resistive Isolation Of Capacitive Load

8 Application and Implementation

NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

8.1 Application Information

The LPV542 is a ultra-low power operational amplifier that provides 8 kHz bandwidth with only 490nA quiescent current, and near precision offset and drift specifications at a low cost. These rail-to-rail input and output amplifiers are specifically designed for battery-powered applications. The input common-mode voltage range extends to the power-supply rails and the output swings to within millivolts of the rails, maintaining a wide dynamic range.

8.2 Typical Application: 60 Hz Twin "T" Notch Filter

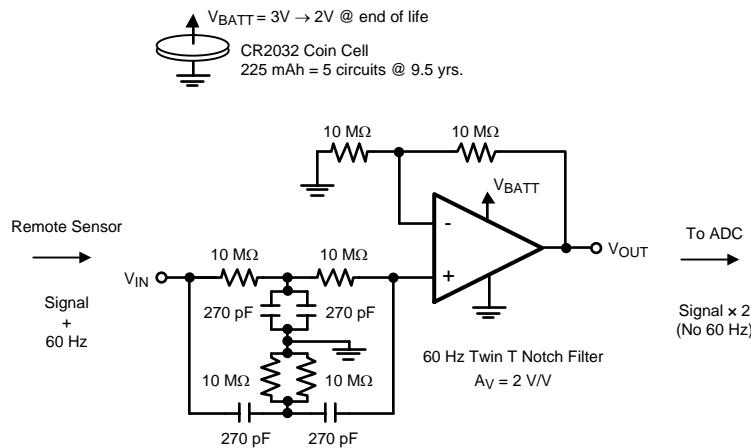


Figure 39. 60 Hz Notch Filter

8.2.1 Design Requirements

Small signals from transducers in remote and distributed sensing applications commonly suffer strong 60 Hz interference from AC power lines. The circuit of Figure 39 notches out the 60 Hz and provides a gain $A_V = 2$ for the sensor signal represented by a 1 kHz sine wave. Similar stages may be cascaded to remove 2nd and 3rd harmonics of 60 Hz. Thanks to the nA power consumption of the LPV542, even 5 such circuits can run for 9.5 years from a small CR2032 lithium cell. These batteries have a nominal voltage of 3 V and an end of life voltage of 2 V. With an operating voltage from 1.6 V to 5.5 V the LPV542 can function over this voltage range.

8.2.2 Detailed Design Procedure

The notch frequency is set by:

$$F_0 = 1 / 2\pi RC. \quad (2)$$

To achieve a 60 Hz notch use $R = 10 \text{ M}\Omega$ and $C = 270 \text{ pF}$. If eliminating 50 Hz noise, which is common in European systems, use $R = 11.8 \text{ M}\Omega$ and $C = 270 \text{ pF}$.

The Twin T Notch Filter works by having two separate paths from V_{IN} to the amplifier's input. A low frequency path through the series input resistors and another separate high frequency path through the series input capacitors. However, at frequencies around the notch frequency, the two paths have opposing phase angles and the two signals will tend to cancel at the amplifier's input.

Typical Application: 60 Hz Twin "T" Notch Filter (continued)

To ensure that the target center frequency is achieved and to maximize the notch depth (Q factor) the filter needs to be as balanced as possible. To obtain circuit balance, while overcoming limitations of available standard resistor and capacitor values, use passives in parallel to achieve the 2C and R/2 circuit requirements for the filter components that connect to ground.

To make sure passive component values stay as expected clean board with alcohol, rinse with deionized water, and air dry. Make sure board remains in a relatively low humidity environment to minimize moisture which may increase the conductivity of board components. Also large resistors come with considerable parasitic stray capacitance which effects can be reduced by cutting out the ground plane below components of concern.

Large resistors are used in the feedback network to minimize battery drain. When designing with large resistors, resistor thermal noise, op amp current noise, as well as op amp voltage noise, must be considered in the noise analysis of the circuit. The noise analysis for the circuit in [Figure 39](#) can be done over a bandwidth of 2 kHz, which takes the conservative approach of overestimating the bandwidth (LPV542 typical GBW/A_V is lower). The total noise at the output is approximately 800 μ Vpp, which is excellent considering the total consumption of the circuit is only 900 nA. The dominant noise terms are op amp voltage noise, current noise through the feedback network (430 μ Vpp), and current noise through the notch filter network (280 μ Vpp). Thus the total circuit's noise is below 1/2 LSB of a 10-bit system with a 2 V reference, which is 1 mV.

8.2.3 Application Curve

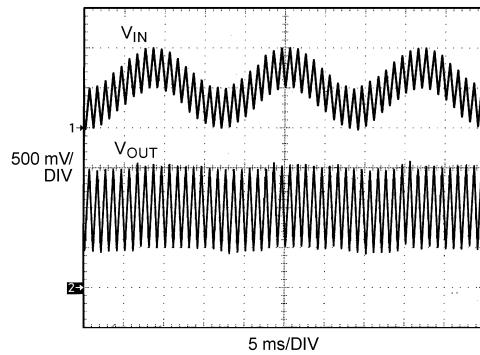


Figure 40. 60 Hz Notch Filter Waveform

8.3 Do's and Don'ts

Do properly bypass the power supplies.

Do add series resistance to the output when driving capacitive loads, particularly cables, Muxes and ADC inputs.

Do add series current limiting resistors and external schottky clamp diodes if input voltage is expected to exceed the supplies. Limit the current to 1 mA or less (1 K Ω per volt).

9 Power Supply Recommendations

The LPV542 is specified for operation from 1.6 V to 5.5 V (± 0.8 V to ± 2.75 V) over a -40°C to 125°C temperature range. Parameters that can exhibit significant variance with regard to operating voltage or temperature are presented in the [Typical Characteristics](#).

CAUTION

Supply voltages larger than 6 V can permanently damage the device.

For proper operation, the power supplies must be properly decoupled. For decoupling the supply lines it is suggested that 10 nF capacitors be placed as close as possible to the operational amplifier power supply pins. For single supply, place a capacitor between V^+ and V^- supply leads. For dual supplies, place one capacitor between V^+ and ground, and one capacitor between V^- and ground.

Low bandwidth nanopower devices do not have good high frequency (> 1 kHz) AC PSRR rejection against high-frequency switching supplies and other 1 kHz and above noise sources, so extra supply filtering is recommended if kilohertz or above noise is expected on the power supply lines.

10 Layout

10.1 Layout Guidelines

The V^+ pin should be bypassed to ground with a low ESR capacitor.

The optimum placement is closest to the V^+ and ground pins.

Care should be taken to minimize the loop area formed by the bypass capacitor connection between V^+ and ground.

The ground pin should be connected to the PCB ground plane at the pin of the device.

The feedback components should be placed as close to the device as possible to minimize strays.

There is an internal electrical connection between the exposed Die Attach Pad (DAP) and the V^- pin. For best performance the DAP should be connected to the exact same potential as the V^- pin. Do not use the DAP as the primary V^- supply. Floating the DAP pad is not recommended. The DAP and V^- pin should be joined directly as shown in the [Layout Example](#).

10.2 Layout Example

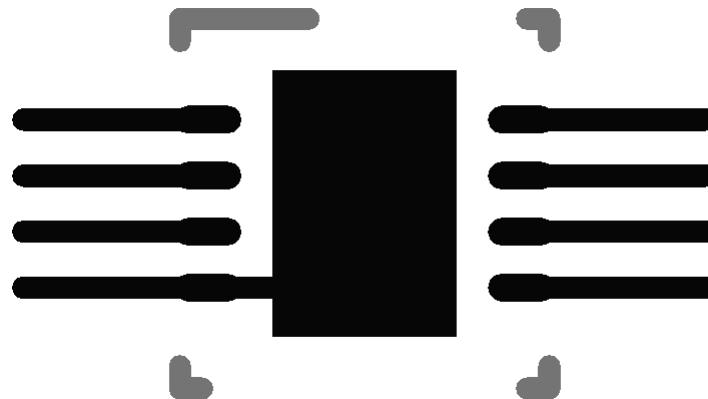


Figure 41. X1SON Layout Example (top view)

11 器件和文档支持

11.1 器件支持

11.1.1 开发支持

TINA-TI 基于 SPICE 的模拟仿真程序, <http://www.ti.com.cn/tool/cn/tina-ti>

DIP 适配器评估模块, <http://www.ti.com.cn/tool/cn/dip-adapter-evm>

TI 通用运行放大器评估模块, <http://www.ti.com.cn/tool/cn/opampevm>

TI FilterPro 滤波器设计软件, <http://www.ti.com.cn/tool/cn/filterpro>

11.2 文档支持

11.2.1 相关文档

相关文档如下:

- AN-1798 《设计电化学传感器》, [SNOA514](#)
- AN-1803 《互阻抗放大器设计注意事项》, [SNOA515](#)
- AN-1852 《设计 pH 电极》, [SNOA529](#)
- 《直观补偿互阻抗放大器》, [SBOA055](#)
- 《高速运算放大器互阻抗注意事项》, [SBOA112](#)
- 《FET 互阻抗放大器噪声分析》, [SBOA060](#)
- 《电路板布局布线技巧》, [SLOA089](#)
- 《运算放大器应用手册》, [SBOA092](#)

11.3 商标

All trademarks are the property of their respective owners.

11.4 静电放电警告



这些装置包含有限的内置 ESD 保护。存储或装卸时, 应将导线一起截短或将装置放置于导电泡棉中, 以防止 MOS 门极遭受静电损伤。

11.5 术语表

[SLYZ022](#) — TI 术语表。

这份术语表列出并解释术语、首字母缩略词和定义。

12 机械封装和可订购信息

以下页中包括机械封装和可订购信息。这些信息是针对指定器件可提供的最新数据。这些数据会在无通知且不对本文档进行修订的情况下发生改变。欲获得该数据表的浏览器版本, 请查阅左侧的导航栏。

重要声明

德州仪器(TI) 及其下属子公司有权根据 **JESD46** 最新标准, 对所提供的产品和服务进行更正、修改、增强、改进或其它更改, 并有权根据 **JESD48** 最新标准中止提供任何产品和服务。客户在下订单前应获取最新的相关信息, 并验证这些信息是否完整且是最新的。所有产品的销售都遵循在订单确认时所提供的**TI** 销售条款与条件。

TI 保证其所销售的组件的性能符合产品销售时 **TI** 半导体产品销售条件与条款的适用规范。仅在 **TI** 保证的范围内, 且 **TI** 认为有必要时才会使用测试或其它质量控制技术。除非适用法律做出了硬性规定, 否则没有必要对每种组件的所有参数进行测试。

TI 对应用帮助或客户产品设计不承担任何义务。客户应对其使用 **TI** 组件的产品和应用自行负责。为尽量减小与客户产品和应用相关的风险, 客户应提供充分的设计与操作安全措施。

TI 不对任何 **TI** 专利权、版权、屏蔽作品权或其它与使用了 **TI** 组件或服务的组合设备、机器或流程相关的 **TI** 知识产权中授予的直接或隐含权限作出任何保证或解释。**TI** 所发布的与第三方产品或服务有关的信息, 不能构成从 **TI** 获得使用这些产品或服务的许可、授权、或认可。使用此类信息可能需要获得第三方的专利权或其它知识产权方面的许可, 或是 **TI** 的专利权或其它知识产权方面的许可。

对于 **TI** 的产品手册或数据表中 **TI** 信息的重要部分, 仅在没有对内容进行任何篡改且带有相关授权、条件、限制和声明的情况下才允许进行复制。**TI** 对此类篡改过的文件不承担任何责任或义务。复制第三方的信息可能需要服从额外的限制条件。

在转售 **TI** 组件或服务时, 如果对该组件或服务参数的陈述与 **TI** 标明的参数相比存在差异或虚假成分, 则会失去相关 **TI** 组件或服务的所有明示或暗示授权, 且这是不正当的、欺诈性商业行为。**TI** 对任何此类虚假陈述均不承担任何责任或义务。

客户认可并同意, 尽管任何应用相关信息或支持仍可能由 **TI** 提供, 但他们将独自负责满足与其产品及在其应用中使用 **TI** 产品相关的所有法律、法规和安全相关要求。客户声明并同意, 他们具备制定与实施安全措施所需的全部专业技术和知识, 可预见故障的危险后果、监测故障及其后果、降低有可能造成人身伤害的故障的发生机率并采取适当的补救措施。客户将全额赔偿因在此类安全关键应用中使用任何 **TI** 组件而对 **TI** 及其代理造成任何损失。

在某些场合中, 为了推进安全相关应用有可能对 **TI** 组件进行特别的促销。**TI** 的目标是利用此类组件帮助客户设计和创立其特有的可满足适用的功能安全性标准和要求的终端产品解决方案。尽管如此, 此类组件仍然服从这些条款。

TI 组件未获得用于 **FDA Class III** (或类似的生命攸关医疗设备) 的授权许可, 除非各方授权官员已经达成了专门管控此类使用的特别协议。

只有那些 **TI** 特别注明属于军用等级或“增强型塑料”的 **TI** 组件才是设计或专门用于军事/航空应用或环境的。购买者认可并同意, 对并非指定面向军事或航空航天用途的 **TI** 组件进行军事或航空航天方面的应用, 其风险由客户单独承担, 并且由客户独自负责满足与此类使用相关的所有法律和法规要求。

TI 已明确指定符合 **ISO/TS16949** 要求的产品, 这些产品主要用于汽车。在任何情况下, 因使用非指定产品而无法达到 **ISO/TS16949** 要求, **TI** 不承担任何责任。

产品	应用
数字音频	www.ti.com.cn/audio
放大器和线性器件	www.ti.com.cn/amplifiers
数据转换器	www.ti.com.cn/dataconverters
DLP® 产品	www.dlp.com
DSP - 数字信号处理器	www.ti.com.cn/dsp
时钟和计时器	www.ti.com.cn/clockandtimers
接口	www.ti.com.cn/interface
逻辑	www.ti.com.cn/logic
电源管理	www.ti.com.cn/power
微控制器 (MCU)	www.ti.com.cn/microcontrollers
RFID 系统	www.ti.com.cn/rfidsys
OMAP应用处理器	www.ti.com/omap
无线连通性	www.ti.com.cn/wirelessconnectivity
	德州仪器在线技术支持社区 www.deyisupport.com

邮寄地址: 上海市浦东新区世纪大道1568号, 中建大厦32楼邮政编码: 200122
Copyright © 2015, 德州仪器半导体技术(上海)有限公司

PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
LPV542DGKR	ACTIVE	VSSOP	DGK	8	2500	RoHS & Green	NIPDAUAG	Level-1-260C-UNLIM	-40 to 125	LP V542	Samples
LPV542DGKT	ACTIVE	VSSOP	DGK	8	250	RoHS & Green	NIPDAUAG	Level-1-260C-UNLIM	-40 to 125	LP V542	Samples
LPV542DNXR	ACTIVE	X1SON	DNX	8	3000	RoHS & Green	NIPDAUAG	Level-1-260C-UNLIM	-40 to 125	LPV542	Samples
LPV542DNXT	ACTIVE	X1SON	DNX	8	250	RoHS & Green	NIPDAUAG	Level-1-260C-UNLIM	-40 to 125	LPV542	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBsolete: TI has discontinued the production of the device.

(2) **RoHS:** TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

Important Information and Disclaimer: The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and



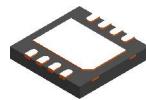
www.ti.com

PACKAGE OPTION ADDENDUM

10-Dec-2020

continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

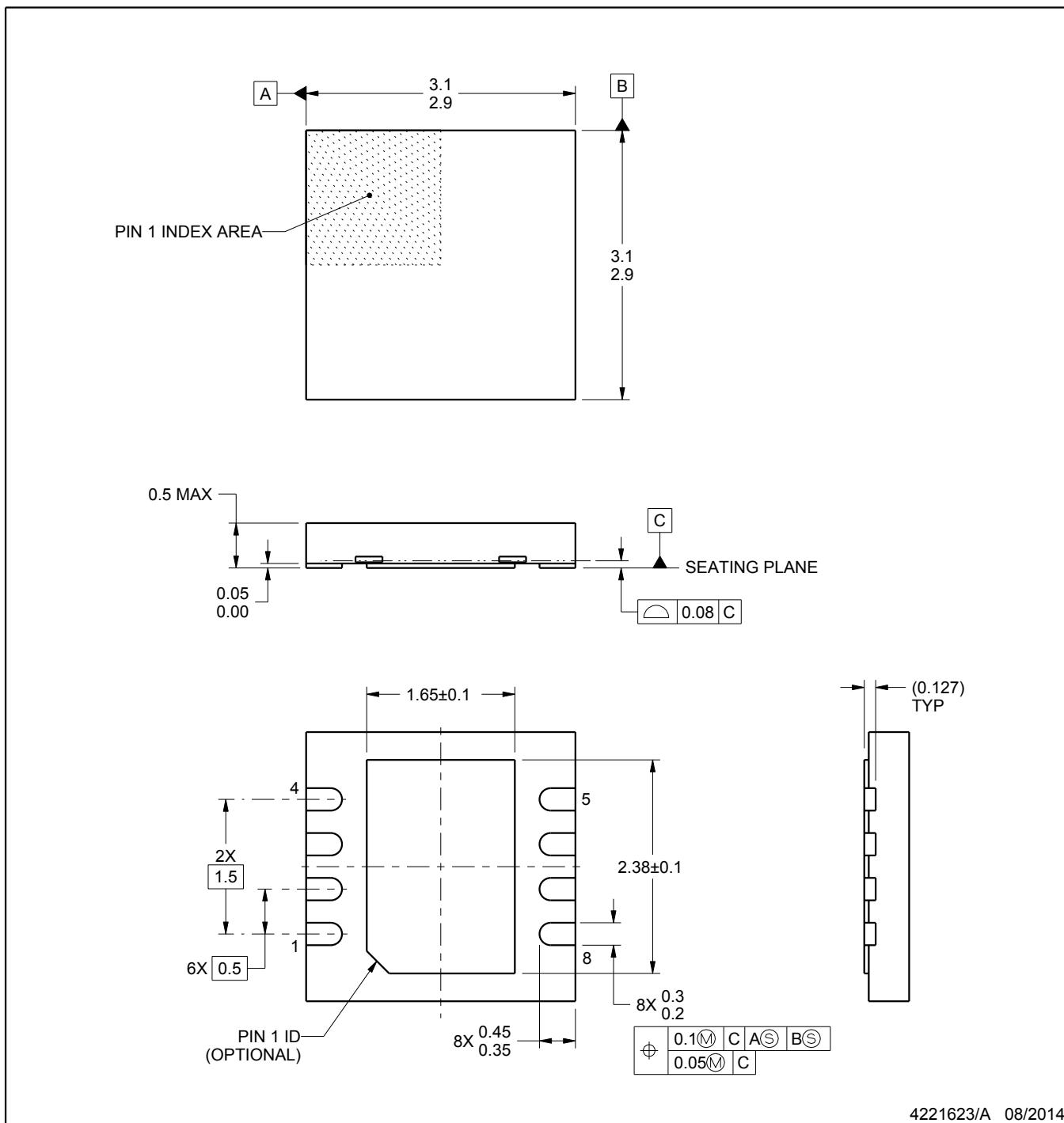


PACKAGE OUTLINE

DNX0008A

X1SON - 0.5 mm max height

PLASTIC SMALL OUTLINE - NO LEAD



4221623/A 08/2014

NOTES:

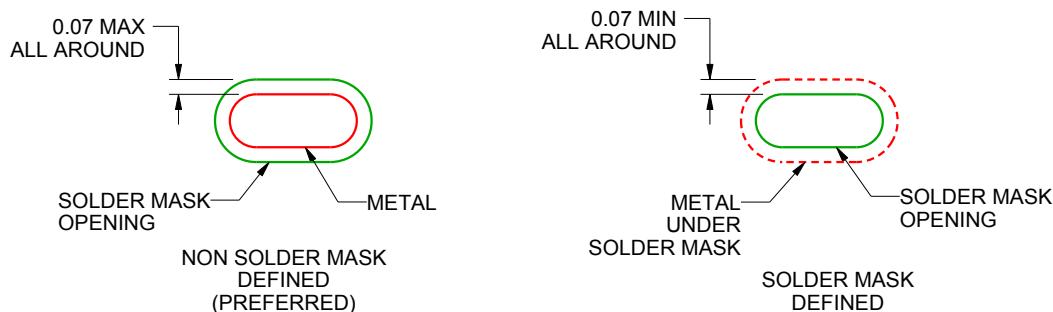
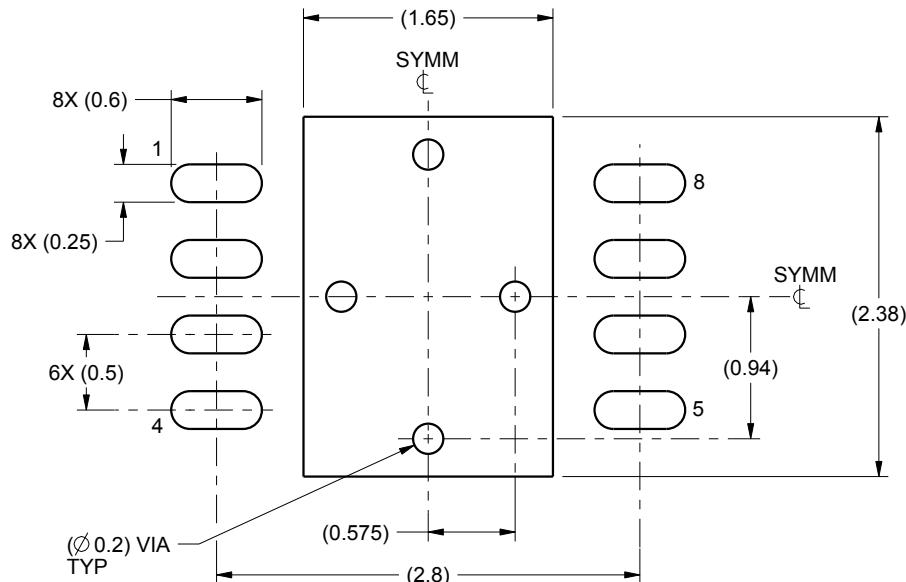
1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. The package thermal pad must be soldered to the printed circuit board for thermal and mechanical performance.

EXAMPLE BOARD LAYOUT

DNX0008A

X1SON - 0.5 mm max height

PLASTIC SMALL OUTLINE - NO LEAD



4221623/A 08/2014

NOTES: (continued)

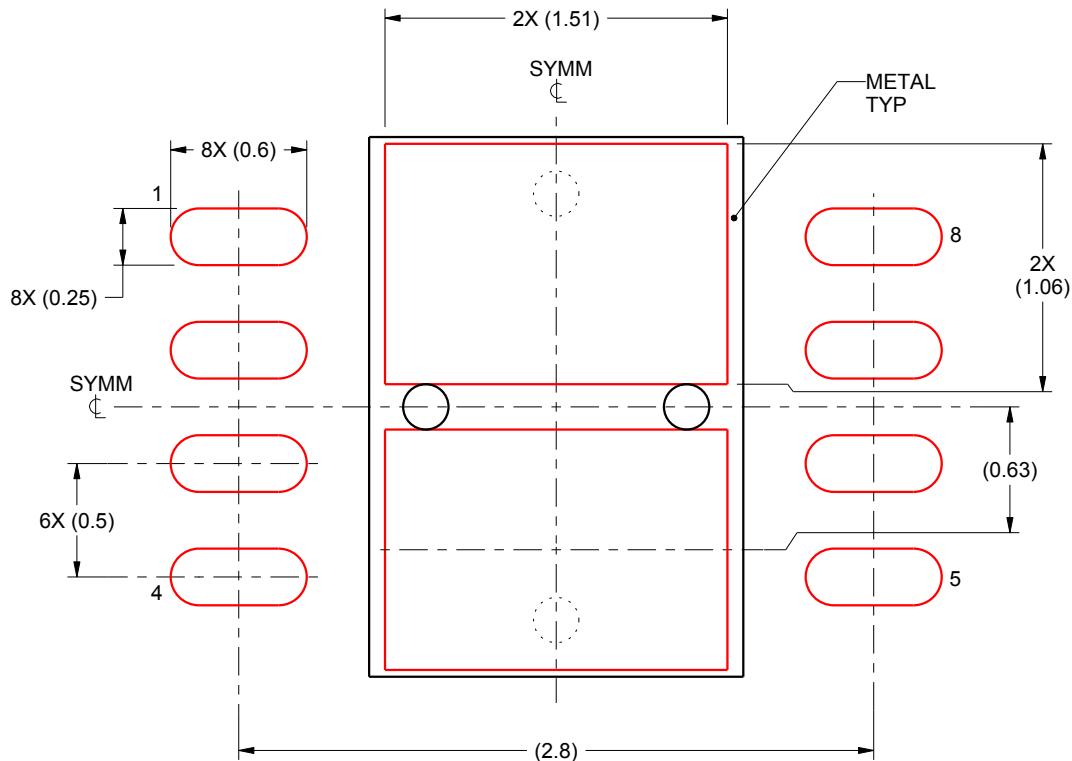
4. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).

EXAMPLE STENCIL DESIGN

DNX0008A

X1SON - 0.5 mm max height

PLASTIC SMALL OUTLINE - NO LEAD



SOLDER PASTE EXAMPLE BASED ON 0.125 mm THICK STENCIL

EXPOSED PAD
82% PRINTED SOLDER COVERAGE BY AREA
SCALE:30X

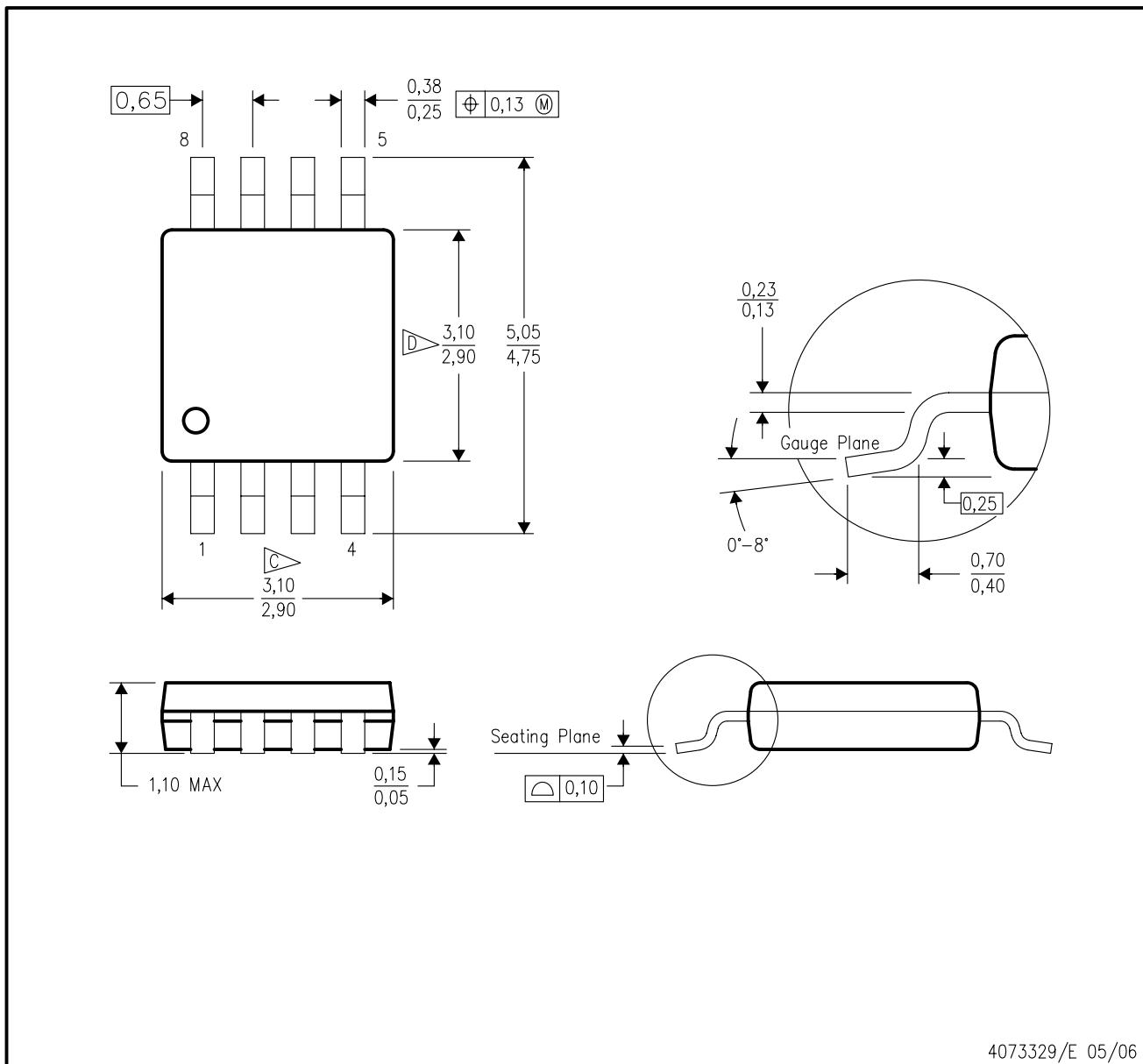
4221623/A 08/2014

NOTES: (continued)

5. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

DGK (S-PDSO-G8)

PLASTIC SMALL-OUTLINE PACKAGE

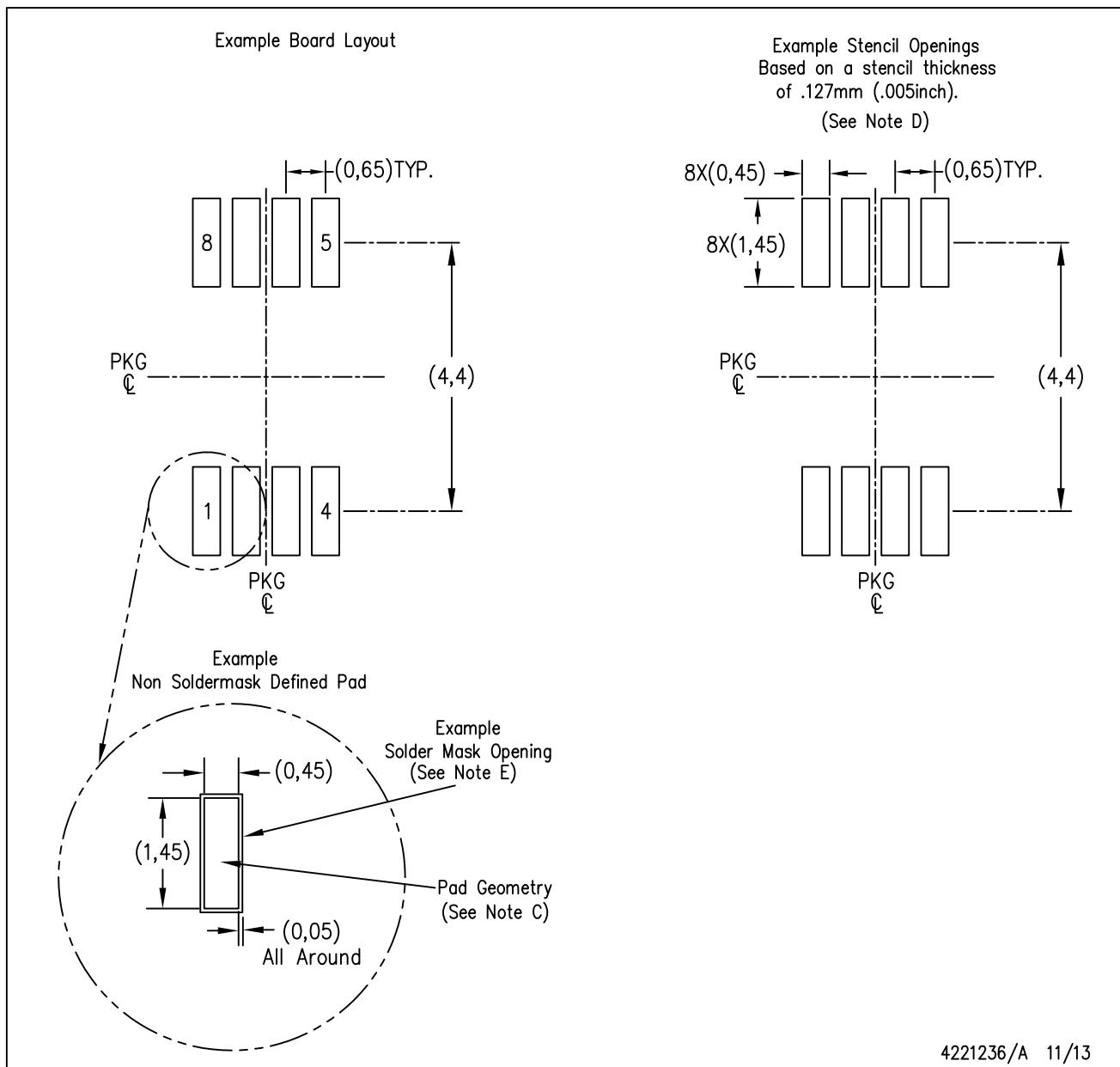


NOTES:

- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- Body** Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0,15 per end.
- Body width** does not include interlead flash. Interlead flash shall not exceed 0,50 per side.
- E. Falls within JEDEC MO-187 variation AA, except interlead flash.

DGK (S-PDSO-G8)

PLASTIC SMALL OUTLINE PACKAGE



NOTES:

- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.

重要声明和免责声明

TI 均以“原样”提供技术性及可靠性数据（包括数据表）、设计资源（包括参考设计）、应用或其他设计建议、网络工具、安全信息和其他资源，不保证其中不含任何瑕疵，且不做任何明示或暗示的担保，包括但不限于对适销性、适合某特定用途或不侵犯任何第三方知识产权的暗示担保。

所述资源可供专业开发人员应用TI 产品进行设计使用。您将对以下行为独自承担全部责任：(1) 针对您的应用选择合适的TI 产品；(2) 设计、验证并测试您的应用；(3) 确保您的应用满足相应标准以及任何其他安全、安保或其他要求。所述资源如有变更，恕不另行通知。TI 对您使用所述资源的授权仅限于开发资源所涉及TI 产品的相关应用。除此之外不得复制或展示所述资源，也不提供其它TI 或任何第三方的知识产权授权许可。如因使用所述资源而产生任何索赔、赔偿、成本、损失及债务等，TI 对此概不负责，并且您须赔偿由此对TI 及其代表造成的损害。

TI 所提供产品均受TI 的销售条款 (<http://www.ti.com.cn/zh-cn/legal/termsofsale.html>) 以及ti.com.cn 上或随附TI 产品提供的其他可适用条款的约束。TI 提供所述资源并不扩展或以其他方式更改TI 针对TI 产品所发布的可适用的担保范围或担保免责声明。

邮寄地址：上海市浦东新区世纪大道 1568 号中建大厦 32 楼，邮政编码：200122
Copyright © 2020 德州仪器半导体技术（上海）有限公司